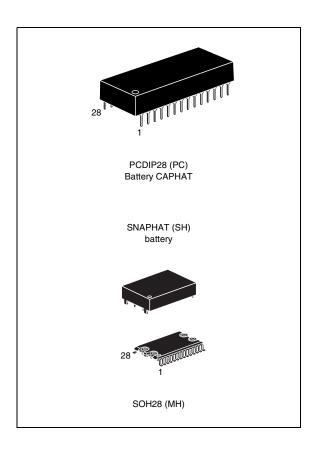


5V, 64Kbit (8Kbit x 8) ZEROPOWER ® SRAM

Features

- Integrated, ultra low power SRAM, power-fail control circuit, and battery
- READ cycle time equals WRITE cycle time
- Automatic power-fail chip deselect and WRITE protection
- WRITE protect voltages: (V_{PFD} = Power-fail deselect voltage)
 - M48Z58: $V_{CC} = 4.75$ to 5.5V $4.5V \le V_{PFD} \le 4.75V$
 - M48Z58Y: V_{CC} = 4.5 to 5.5V 4.2V $\leq V_{PFD} \leq$ 4.5V
- Self-contained battery in the CAPHATTM DIP package
- Packaging includes a 28-lead SOIC and SNAPHAT® top (to be ordered separately)
- SOIC package provides direct connection for a SNAPHAT top which contains the battery
- Pin and function compatible with JEDEC standard 8Kbit x 8 SRAMs
- RoHS compliant
 - Lead-free second level interconnect



Contents M48Z58, M48Z58Y

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M48Z58, M48Z58Y Description

1 Description

The M48Z58/Y ZEROPOWER[®] RAM is an 8Kbit x 8 non-volatile static RAM that integrates power-fail deselect circuitry and battery control logic on a single die. The monolithic chip is available in two special packages to provide a highly integrated battery backed-up memory solution.

The M48Z58/Y is a non-volatile pin and function equivalent to any JEDEC standard 8K x 8 SRAM. It also easily fits into many ROM, EPROM, and EEPROM sockets, providing the non-volatility of PROMs without any requirement for special WRITE timing or limitations on the number of WRITEs that can be performed.

The 28-pin, 600mil DIP CAPHAT™ houses the M48Z58/Y silicon with a long life lithium button cell in a single package.

The 28-pin, 330mil SOIC provides sockets with gold plated contacts at both ends for direct connection to a separate SNAPHAT® housing containing the battery. The unique design allows the SNAPHAT battery package to be mounted on top of the SOIC package after the completion of the surface mount process. Insertion of the SNAPHAT housing after reflow prevents potential battery damage due to the high temperatures required for device surface-mounting. The SNAPHAT housing is keyed to prevent reverse insertion.

The SOIC and battery packages are shipped separately in plastic anti-static tubes or in Tape & Reel form.

For the 28-lead SOIC, the battery package (e.g., SNAPHAT) part number is "M4Z28-BR00SH1" (see *Table 16 on page 21*).

Figure 1. Logic diagram

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Description M48Z58, M48Z58Y

Table 1. Signal names

A0-A12	Address inputs
DQ0-DQ7	Data inputs / outputs
E	Chip enable input
G	Output enable input
W	WRITE enable input
V _{CC}	Supply voltage
V _{SS}	Ground
NC	Not connected internally

Figure 2. DIP connections

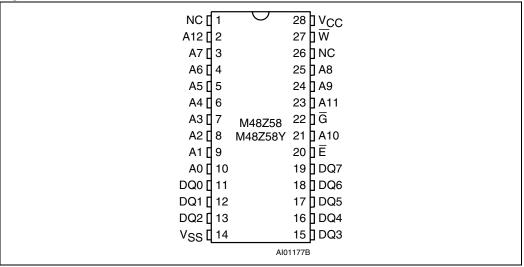
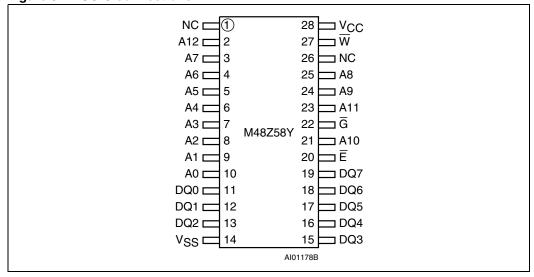
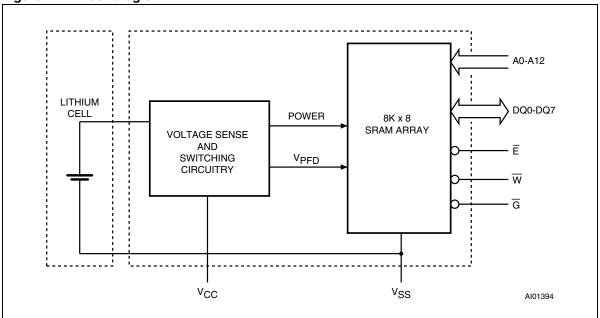


Figure 3. SOIC connections



M48Z58, M48Z58Y Description

Figure 4. Block diagram



Operating modes M48Z58, M48Z58Y

2 Operating modes

The M48Z58/Y also has its own Power-fail Detect circuit. The control circuitry constantly monitors the single 5V supply for an out of tolerance condition. When V_{CC} is out of tolerance, the circuit write protects the SRAM, providing a high degree of data security in the midst of unpredictable system operation brought on by low V_{CC} . As V_{CC} falls below battery switchover voltage (V_{SO}), the control circuitry connects the battery which maintains data until valid power returns.

Table 2. Operating modes

Mode	v _{cc}	E	G	W	DQ0-DQ7	Power
Deselect		V _{IH}	Х	Х	High Z	Standby
WRITE	4.75 to 5.5V or	V _{IL}	Х	V _{IL}	D _{IN}	Active
READ	4.5 to 5.5V	V _{IL}	V _{IL}	V _{IH}	D _{OUT}	Active
READ		V _{IL}	V _{IH}	V _{IH}	High Z	Active
Deselect	V _{SO} to V _{PFD} (min) ⁽¹⁾	Х	Х	Х	High Z	CMOS standby
Deselect	≤ V _{SO} ⁽¹⁾⁽¹⁾	Х	Х	Х	High Z	Battery back-up mode

^{1.} See Table 10 on page 16 for details.

Note: $X = V_{IH}$ or V_{IL} ; $V_{SO} = Battery\ Back-up\ Switchover\ Voltage$.

2.1 Read mode

The M48Z58/Y is in the READ Mode whenever \overline{W} (WRITE Enable) is high, \overline{E} (Chip Enable) is low. Thus, the unique address specified by the 13 Address Inputs defines which one of the 8,192 bytes of data is to be accessed. Valid data will be available at the Data I/O pins within Address Access time (t_{AVQV}) after the last address input signal is stable, providing that the \overline{E} and \overline{G} access times are also satisfied. If the \overline{E} and \overline{G} access times are not met, valid data will be available after the latter of the Chip Enable Access time (t_{ELQV}) or Output Enable Access time (t_{GLQV}).

The state of the eight three-state Data I/O signals is controlled by \overline{E} and \overline{G} . If the outputs are activated before t_{AVQV} , the data lines will be driven to an indeterminate state until t_{AVQV} . If the Address Inputs are changed while \overline{E} and \overline{G} remain active, output data will remain valid for Output Data Hold time (t_{AXQX}) but will go indeterminate until the next Address Access.

M48Z58, M48Z58Y Operating modes

A0-A12

VALID

tAVQV

tELQV

tGLQV

tGLQX

A00-DQ7

Figure 5. Read mode AC waveforms

Note: $WRITE\ Enable\ (\overline{W}) = High.$

Table 3. Read mode AC characteristics

Symbol	Parameter ⁽¹⁾	M482	Unit	
Syllibol	raiameter	Min	Max	Oilit
t _{AVAV}	READ cycle time	70		ns
t _{AVQV}	Address valid to output valid		70	ns
t _{ELQV}	Chip enable low to output valid		70	ns
t _{GLQV}	Output enable low to output valid		35	ns
t _{ELQX} (2)	Chip enable low to output transition	5		ns
t _{GLQX} (2)	Output enable low to output transition	5		ns
t _{EHQZ} (2)	Chip enable high to output Hi-Z		25	ns
t _{GHQZ} (2)	Output enable high to output Hi-Z		25	ns
t _{AXQX}	Address transition to output transition	10		ns

^{1.} Valid for ambient operating temperature: $T_A = 0$ to $70^{\circ}C$; $V_{CC} = 4.75$ to 5.5V or 4.5 to 5.5V (except where noted).

2.2 Write mode

The M48Z58/Y is in the WRITE Mode whenever \overline{W} and \overline{E} are low. The start of a WRITE is referenced from the latter occurring falling edge of \overline{W} or \overline{E} . A WRITE is terminated by the earlier rising edge of \overline{W} or \overline{E} . The addresses must be held valid throughout the cycle. \overline{E} or \overline{W} must return high for a minimum of t_{EHAX} from Chip Enable or t_{WHAX} from WRITE Enable prior to the initiation of another READ or WRITE cycle. Data-in must be valid t_{DVWH} prior to the end of WRITE and remain valid for t_{WHDX} afterward. \overline{G} should be kept high during WRITE cycles to avoid bus contention; although, if the output bus has been activated by a low on \overline{E} and \overline{G} , a low on \overline{W} will disable the outputs t_{WLQZ} after \overline{W} falls.

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^{2.} $C_L = 5pF$ (see Figure 9 on page 14).

Operating modes M48Z58, M48Z58Y

Figure 6. Write enable controlled, write mode AC waveforms

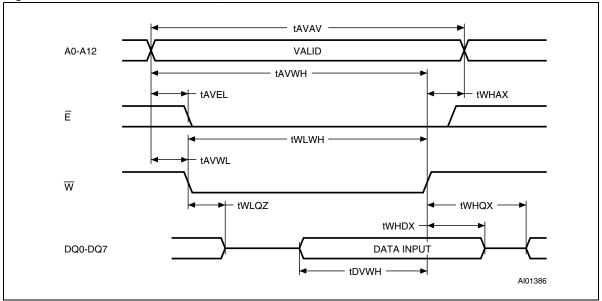
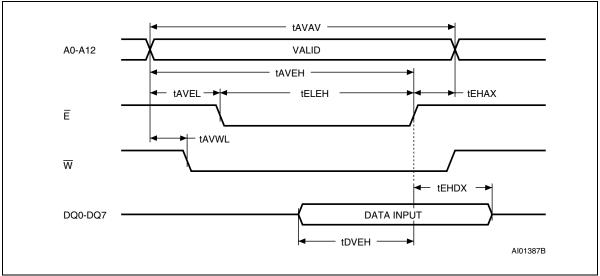


Figure 7. Chip enable controlled, write mode AC waveforms



M48Z58, M48Z58Y Operating modes

Table 4. Write mode AC characteristics

Cumbal	Parameter ⁽¹⁾	M482	Z58/Y	Unit
Symbol	Parameter	Min	Max	Unit
t _{AVAV}	WRITE cycle time	70		ns
t _{AVWL}	Address valid to WRITE enable low	0		ns
t _{AVEL}	Address valid to chip enable low	0		ns
t _{WLWH}	WRITE enable pulse width	50		ns
t _{ELEH}	Chip enable low to chip enable high	55		ns
t _{WHAX}	WRITE enable high to address transition	0		ns
t _{EHAX}	Chip enable high to address transition	0		ns
t _{DVWH}	Input valid to WRITE enable high	30		ns
t _{DVEH}	Input valid to chip enable high	30		ns
t _{WHDX}	WRITE enable high to input transition	5		ns
t _{EHDX}	Chip enable high to input transition	5		ns
t _{WLQZ} (2)(3)	WRITE enable low to output Hi-Z		25	ns
t _{AVWH}	Address valid to WRITE enable high	60		ns
t _{AVEH}	Address valid to chip enable high	60		ns
t _{WHQX} (2)(3)	WRITE enable high to output transition	5		ns

Valid for ambient operating temperature: T_A = 0 to 70°C; V_{CC} = 4.75 to 5.5V or 4.5 to 5.5V (except where noted).

2.3 Data retention mode

With valid V_{CC} applied, the M48Z58/Y operates as a conventional BYTEWIDETM static RAM. Should the supply voltage decay, the RAM will automatically power-fail deselect, write protecting itself when V_{CC} falls within the V_{PFD} (max), V_{PFD} (min) window. All outputs become high impedance, and all inputs are treated as "Don't care."

Note:

A power failure during a WRITE cycle may corrupt data at the currently addressed location, but does not jeopardize the rest of the RAM's content. At voltages below V_{PFD} (min), the user can be assured the memory will be in a write protected state, provided the V_{CC} fall time is not less than t_F The M48Z58/Y may respond to transient noise spikes on V_{CC} that reach into the deselect window during the time the device is sampling V_{CC} . Therefore, decoupling of the power supply lines is recommended.

When V_{CC} drops below V_{SO} , the control circuit switches power to the internal battery which preserves data. The internal button cell will maintain data in the M48Z58/Y for an accumulated period of at least 10 years when V_{CC} is less than V_{SO} .

As system power returns and V_{CC} rises above V_{SO} , the battery is disconnected, and the power supply is switched to external V_{CC} . Normal RAM operation can resume t_{rec} after V_{CC} exceeds V_{PFD} (max).

For more information on Battery Storage Life refer to the Application Note AN1012.

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^{2.} $C_L = 5pF$ (see Figure 9 on page 14).

^{3.} If \overline{E} goes low simultaneously with \overline{W} going low, the outputs remain in the high impedance state.

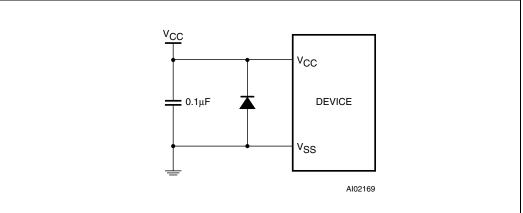
Operating modes M48Z58, M48Z58Y

2.4 V_{CC} noise and negative going transients

 I_{CC} transients, including those produced by output switching, can produce voltage fluctuations, resulting in spikes on the V_{CC} bus. These transients can be reduced if capacitors are used to store energy which stabilizes the V_{CC} bus. The energy stored in the bypass capacitors will be released as low going spikes are generated or energy will be absorbed when overshoots occur. A ceramic bypass capacitor value of 0.1 μ F (see *Figure 8*) is recommended in order to provide the needed filtering.

In addition to transients that are caused by normal SRAM operation, power cycling can generate negative voltage spikes on V_{CC} that drive it to values below V_{SS} by as much as one volt. These negative spikes can cause data corruption in the SRAM while in battery backup mode. To protect from these voltage spikes, ST recommends connecting a schottky diode from V_{CC} to V_{SS} (cathode connected to V_{CC} , anode to V_{SS}). (Schottky diode 1N5817 is recommended for through hole and MBRS120T3 is recommended for surface mount).

Figure 8. Supply voltage protection



M48Z58, M48Z58Y Maximum rating

3 Maximum rating

Stressing the device above the rating listed in the "Absolute Maximum Ratings" table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

Table 5. Absolute maximum ratings

Symbol	Parameter	Value	Unit	
T _A	Ambient operating temperature		0 to 70	°C
		SNAPHAT [®] top	-40 to 85	°C
T_{STG}	Storage temperature (V _{CC} off, oscillator off) CAPHAT® DIP SOIC	CAPHAT [®] DIP	-40 to 85	°C
		-55 to 125	°C	
T _{SLD} ⁽¹⁾⁽²⁾	Lead solder temperature for 10 seconds		260	°C
V _{IO}	Input or output voltages		-0.3 to 7.0	V
V _{CC}	Supply voltage		-0.3 to 7.0	V
I _O	Output current		20	mA
P _D	Power dissipation		1	W

For DIP package: Soldering temperature not to exceed 260°C for 10 seconds (total thermal budget not to exceed 150°C for longer than 30 seconds).

Caution: Negative undershoots below -0.3V are not allowed on any pin while in the battery back-up

mode.

Caution: Do NOT wave solder SOIC to avoid damaging SNAPHAT sockets.

^{2.} For SO package, Lead-free (Pb-free) lead finish: Reflow at peak temperature of 260°C (total thermal budget not to exceed 245°C for greater than 30 seconds).

4 DC and AC parameters

This section summarizes the operating and measurement conditions, as well as the DC and AC characteristics of the device. The parameters in the following DC and AC Characteristic tables are derived from tests performed under the Measurement Conditions listed in *Table 6: Operating and AC measurement conditions*. Designers should check that the operating conditions in their projects match the measurement conditions when using the quoted parameters.

Table 6. Operating and AC measurement conditions

Parameter	M48Z58	M48Z58Y	Unit
Supply voltage (V _{CC})	4.75 to 5.5V	4.5 to 5.5	V
Ambient operating temperature (T _A)	0 to 70	0 to 70	°C
Load capacitance (C _L)	100	100	pF
Input rise and fall times	≤ 5	≤ 5	ns
Input pulse voltages	0 to 3	0 to 3	V
Input and output timing ref. voltages	1.5	1.5	V

Note: Output Hi-Z is defined as the point where data is no longer driven.

Figure 9. AC measurement load circuit $\begin{array}{c} 5V \\ \hline \\ DEVICE \\ UNDER \\ TEST \\ \hline \\ Ik\Omega \\ \hline \\ C_L \text{ includes JIG capacitance} \\ \end{array}$

Table 7. Capacitance

	Symbol	Parameter ⁽¹⁾⁽²⁾	Min	Max	Unit
Ī	C _{IN}	Input capacitance		10	pF
ſ	C _{IO} (3)	Input / output capacitance		10	pF

- 1. Effective capacitance measured with power supply at 5V. Sampled only, not 100% tested.
- 2. At 25°C, f = 1MHz.
- 3. Outputs deselected.

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Table 8. DC characteristics

Symbol	Parameter	Test condition ⁽¹⁾	Min	Max	Unit
I _{LI}	Input leakage current	$0V \le V_{IN} \le V_{CC}$		±1	μA
I _{LO} ⁽²⁾	Output leakage current	$0V \le V_{OUT} \le V_{CC}$		±1	μA
I _{CC}	Supply current	Outputs open		50	mA
I _{CC1}	Supply current (standby) TTL	E = V _{IH}		3	mA
I _{CC2}	Supply current (standby) CMOS	$\overline{E} = V_{CC} - 0.2V$		3	mA
V _{IL}	Input low voltage		-0.3	0.8	V
V _{IH}	Input high voltage		2.2	V _{CC} + 0.3	V
V _{OL}	Output low voltage	I _{OL} = 2.1mA		0.4	V
V _{OH}	Output high voltage	I _{OH} = -1mA	2.4		V

- 1. Valid for ambient operating temperature: $T_A = 0$ to 70° C; $V_{CC} = 4.75$ to 5.5V or 4.5 to 5.5V (except where noted).
- 2. Outputs deselected.

Figure 10. Power down/up mode AC waveforms

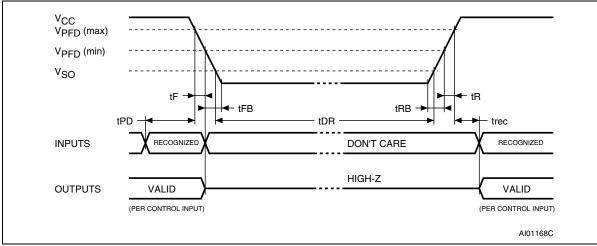


Table 9. Power down/up AC characteristics

Symbol	Parameter ⁽¹⁾	Min	Max	Unit
t _{PD}	E or W at V _{IH} before power down	0		μs
t _F ⁽²⁾	V _{PFD} (max) to V _{PFD} (min) V _{CC} fall time	300		μs
t _{FB} (3)	V _{PFD} (min) to V _{SS} V _{CC} fall time	10		μs
t _R	V _{PFD} (min) to V _{PFD} (max) V _{CC} rise time	10		μs
t _{RB}	V _{SS} to V _{PFD} (min) V _{CC} rise time	1		μs
t _{rec}	V _{PFD} (max) to inputs recognized	40	200	ms

- 1. Valid for ambient operating temperature: $T_A = 0$ to 70° C; $V_{CC} = 4.75$ to 5.5V or 4.5 to 5.5V (except where noted).
- 2. V_{PFD} (max) to V_{PFD} (min) fall time of less than t_F may result in deselection/write protection not occurring until 200µs after V_{CC} passes V_{PFD} (min).
- 3. V_{PFD} (min) to V_{SS} fall time of less than t_{FB} may cause corruption of RAM data.



Table 10. Power down/up trip points DC characteristics

Symbol	Parameter ⁽¹⁾⁽²⁾		Min	Тур	Max	Unit
V	Power-fail deselect voltage	M48Z58	4.5	4.6	4.75	V
V _{PFD}	M48ZS		4.2	4.35	4.5	V
V _{SO}	Battery back-up switchover voltage			3.0		V
t _{DR} ⁽³⁾	Expected data retention time		10			YEARS

- 1. All voltages referenced to V_{SS} .
- 2. Valid for ambient operating temperature: $T_A = 0$ to $70^{\circ}C$; $V_{CC} = 4.75$ to 5.5V or 4.5 to 5.5V (except where noted).
- 3. At 25°C, $V_{CC} = 0V$.

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5 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second Level Interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com.

Figure 11. PCDIP28 – 28-pin plastic DIP, battery CAPHAT™, package outline

Note: Drawing is not to scale.

Table 11. PMDIP28 – 28-pin plastic DIP, battery CAPHAT™, pack. mech. data

Symbol	mm			inches		
	Тур	Min	Max	Тур	Min	Max
А		8.89	9.65		0.350	0.380
A1		0.38	0.76		0.015	0.030
A2		8.38	8.89		0.330	0.350
В		0.38	0.53		0.015	0.021
B1		1.14	1.78		0.045	0.070
С		0.20	0.31		0.008	0.012
D		39.37	39.88		1.550	1.570
Е		17.83	18.34		0.702	0.722
e1		2.29	2.79		0.090	0.110
e3		29.72	36.32		1.170	1.430
eA		15.24	16.00		0.600	0.630
L		3.05	3.81		0.120	0.150
N		28			28	

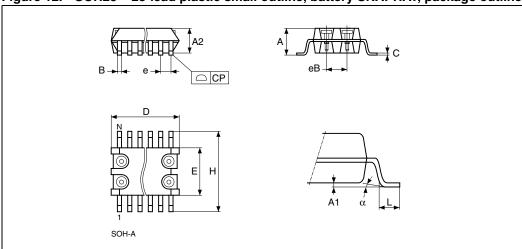


Figure 12. SOH28 – 28-lead plastic small outline, battery SNAPHAT, package outline

Note: Drawing is not to scale.

Table 12. SOH28 – 28-lead plastic small outline, battery SNAPHAT, pack. mech. data

Symbol	mm			inches			
	Тур	Min	Max	Тур	Min	Max	
Α			3.05			0.120	
A1		0.05	0.36		0.002	0.014	
A2		2.34	2.69		0.092	0.106	
В		0.36	0.51		0.014	0.020	
С		0.15	0.32		0.006	0.012	
D		17.71	18.49		0.697	0.728	
E		8.23	8.89		0.324	0.350	
е	1.27	-	-	0.050	-	_	
eB		3.20	3.61		0.126	0.142	
Н		11.51	12.70		0.453	0.500	
L		0.41	1.27		0.016	0.050	
а		0°	8°		0°	8°	
N		28	•		28		
СР			0.10			0.004	

Figure 13. SH – 4-pin SNAPHAT housing for 48mAh battery, package outline

Note: Drawing is not to scale.

Table 13. SH – 4-pin SNAPHAT housing for 48mAh battery, package mechanical data

Comb al	mm			inches			
Symbol	Тур	Min	Max	Тур	Min	Max	
Α			9.78			0.385	
A1		6.73	7.24		0.265	0.285	
A2		6.48	6.99		0.255	0.275	
A3			0.38			0.015	
В		0.46	0.56		0.018	0.022	
D		21.21	21.84		0.835	0.860	
Е		14.22	14.99		0.560	0.590	
eA		15.55	15.95		0.612	0.628	
eB		3.20	3.61		0.126	0.142	
L		2.03	2.29		0.080	0.090	

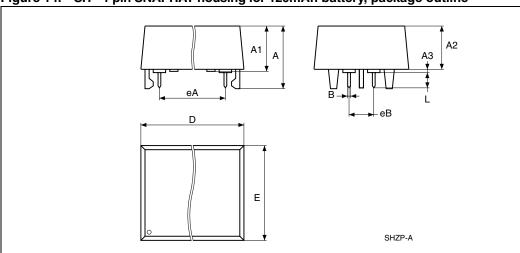


Figure 14. SH –4-pin SNAPHAT housing for 120mAh battery, package outline

Note: Drawing is not to scale.

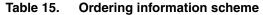
Table 14. SH – 4-pin SNAPHAT housing for 120mAh battery, pack. mech. data

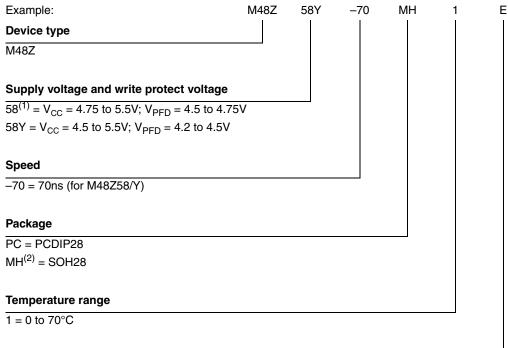
Symb	mm			inches			
	Тур	Min	Max	Тур	Min	Max	
Α			10.54			0.415	
A1		8.00	8.51		0.315	0.335	
A2		7.24	8.00		0.285	0.315	
A3			0.38			0.015	
В		0.46	0.56		0.018	0.022	
D		21.21	21.84		0.835	0.860	
Е		17.27	18.03		0.680	0.710	
eA		15.55	15.95		0.612	0.628	
eB		3.20	3.61		0.126	0.142	
L		2.03	2.29		0.080	0.090	

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M48Z58, M48Z58Y Part numbering

6 Part numbering





Shipping method

For SOH28:

E = ECOPACK package, tubes

F = ECOPACK package, tape & reel

For PCDIP28:

blank = ECOPACK package, tubes

- 1. The M48Z58 part is offered with the PCDIP28 (ie., CAPHAT™) package only.
- The SOIC package (SOH28) requires the SNAPHAT[®] battery package which is ordered separately under the part number "M4Zxx-BR00SH1" in plastic tubes (see *Table 16*).

Caution:

Do not place the SNAPHAT battery package "M4Zxx-BR00SH1" in conductive foam as it will drain the lithium button-cell battery.

For other options, or for more information on any aspect of this device, please contact the ST sales office nearest you.

Table 16. SNAPHAT battery table

Part number	Description	Package
M4Z28-BR00SH1	Lithium Battery (48mAh) SNAPHAT	SH
M4Z32-BR00SH1	Lithium Battery (120mAh) SNAPHAT	SH



Revision history M48Z58, M48Z58Y

7 Revision history

Table 17. Document revision history

Date	Revision	Changes
March 1999	1.0	First issue
10-Feb-2000	1.1	2-socket SOH and 2-pin SH packages removed
22-Feb-2000	1.2	Data retention mode paragraph changed
14-Sep-2001	2.0	Reformatted; added temperature information (<i>Table 7, 8, 3, 4, 9, 10</i>)
29-May-2002	2.1	Modify reflow time and temperature footnotes (Table 5)
16-Sep-2002	2.2	Remove footnote from ordering information (<i>Table 15</i>)
02-Apr-2003	3.0	v2.2 template applied; test condition updated (Table 10)
23-Mar-2004	4.0	Reformatted; updated lead-free information (<i>Table 5</i> , <i>15</i>)
23-Nov-2004	5.0	Remove references to industrial temperature grade (<i>Table 3, 4, 5, 6, 8, 9, 10, 15</i>)
09-Jun-2005	6.0	Removal of SNAPHAT, industrial temperature sales types (<i>Table 3, 4, 5, 6, 7, 8, 10, 15</i>)
14-Dec-2005	7.0	Updated Lead-free text (<i>Table 15</i>)
06-Nov-2007	8.0	Reformatted; added lead-free second level interconnect information to cover page and Section 5: Package mechanical data; updated Table 5, 15, 16.

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